

HA166008MP, HA166009MP,

HA166010MP

Preliminary

Read/Write Circuit

Description

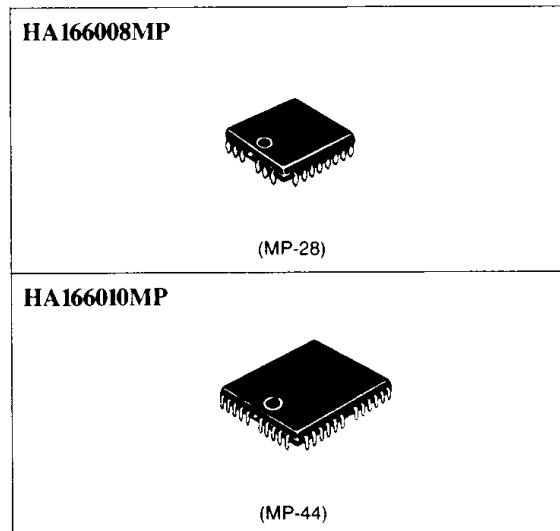
The HA166008MP/009MP/010MP are 4,6 and 8-channel read and write circuit with very low noise amplifier for small hard disk drives.

Functions

- Read amplifier circuit
- Write driver circuit
- Write unsafe detection circuit
- Write current source circuit

Features

- Single polarity power supplies +5V, +12V
- Low noise $\leq 1\text{nV}/\sqrt{\text{Hz}}$
- Read amplifier has a high differential voltage gain of 200typ.
- Emitter followed read amplifier outputs
- Adjustable write current with an external resistor
- Supply voltage monitor circuit (+5V, +12V) inhibit miss writing at the lower supply voltage.
- TTL compatible interface
- Small surface mount package
- I/O pin separated pin arrangement.



Ordering Information

Type No.	Channel	Package
HA166008MP	4	MP-28
HA166009MP	6	MP-28
HA166010MP	8	MP-44

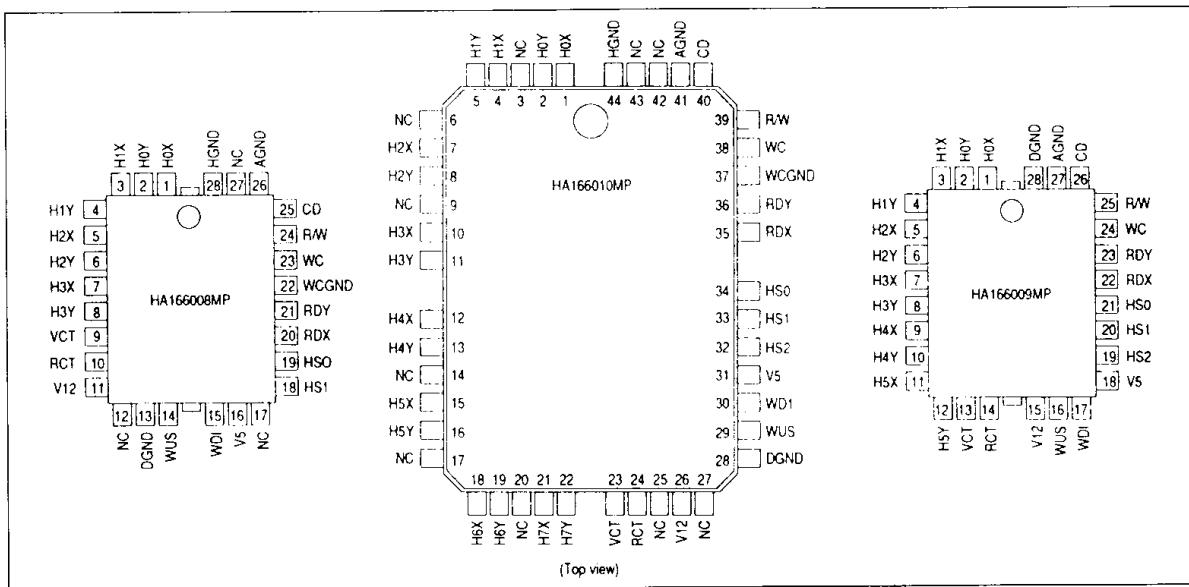


Figure 1 Pin Arrangements



HA166008MP, HA166009MP, HA166010MP

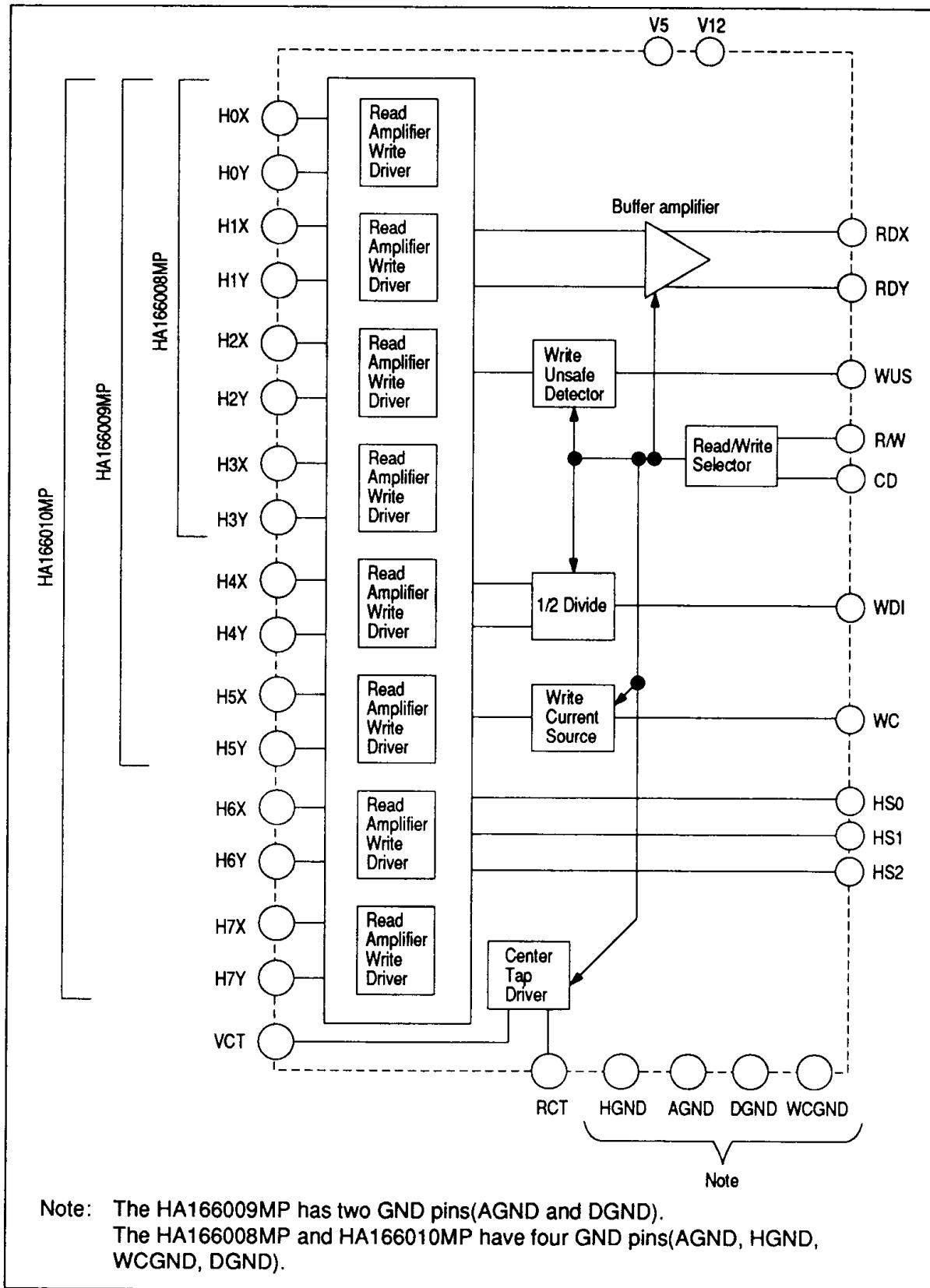


Figure 2 Block Diagram



HA166008MP, HA166009MP, HA166010MP

Table 1 Pin Description

Symbol	Name	Description
RDX RDY	Read amplifier Output	Differential output pins for the read amp The signal read out from the head coil is amplified and provided on these pins.
R/W	R/W switch	Mode select switch for changing over the bias condition of the head coil A low level selects the write mode, while a high level selects the read mode.
CD	Chip disable	Chip select pin. This pin enables more chips to be used for multi channel systems. When selecting a chip, set this pin "Low".
VCT	Center tap voltage output	Center tap voltage output pin for the head coil Current corresponding to the write current flows out from this pin in the write mode.
RCT	Power supply for center tap	The chip power dissipation is reduced by pulling up this pin to the +12V supply with 1/2W and a 130Ω resistor. When the power dissipation has no problem, RCT pin can be pulled up to V ₁₂ voltage directly.
HS0 HS1 HS2	Head select 0 Head select 1 Head select 2	Input pins for head select signals. The combination of these signals selects each one head. Compare with head select table.
H0X, H0Y	Head 0X, 0Y	These pins are connected to the R/W head coil of channel 0.
H1X, H1Y	Head 1X, 1Y	These pins are connected to the R/W head coil of channel 1.
H2X, H2Y	Head 2X, 2Y	These pins are connected to the R/W head coil of channel 2.
H3X, H3Y	Head 3X, 3Y	These pins are connected to the R/W head coil of channel 3.
H4X, H4Y	Head 4X, 4Y	These pins are connected to the R/W head coil of channel 4.
H5X, H5Y	Head 5X, 5Y	These pins are connected to the R/W head coil of channel 5.
H6X, H6Y	Head 6X, 6Y	These pins are connected to the R/W head coil of channel 6.



HA166008MP, HA166009MP, HA166010MP

Pin Description (cont)

H7X, H7Y	Head 7X, 7Y	These pins are connected to the R/W head coil of channel 7.
WC	Write current setting	Write current setting pin. The write current is defined as the equation (1) by connecting the external resistance R_{WC} between this pin and GND. $WRITE\ CURRENT=K/R_{WC} [A] \dots (1)$
WDI	Write data input	Write data input pin. The signal is divided through the F/F circuit in the IC, and drives the write driver.
WUS	Write unsafe detection output	A high level output indicates the unsafe writing conditions. Unsafe conditions are shown as follows, At head pins 1. Short - circuit to ground 2. Open Others 3. Center tap open 4. Extremely low WDI input frequency 5. No write currnet flow 6. All the combinations of the above conditions 7. In the read mode 8. Chip unselected
V5	5V	5V power supply
V12	12V	12V power supply
HGND	Head ground	These are all GND pins.
AGND	Analogue ground	
DGND	Digital ground	
WCGND	WC ground	

Table 2 Absolute Maximum Ratings ($T_a=25^{\circ}\text{C}$)

Item	Symbol	Rating	Unit	Application Terminal
Supply Voltage	V5	-0.3 to 6.0	V	V5
Supply Voltage	V12	-0.3 to 14.0	V	V12
Write Current	Iw	60	mA	
Interface Input Voltage	Vin	-0.3 to V5+0.3	V	HS0, HS1, HS2, WDI, R/W, CD



HA166008MP, HA166009MP, HA166010MP

Absolute Maximum Ratings ($T_a=25^\circ\text{C}$) (cont)

WUS voltage	V_{WUS}	14.0	V	WUS
WUS output current	I_{WUS}	12	mA	WUS
Center tap output current	I_{CO}	-60	mA	VCT
Read data output current	I_{RDY}	-10	mA	RDX, RDY
Head voltage	V_h	-0.3 to 10.0	V	Note
Operating temperature	T_{OPR}	0 to +70	°C	
Storage temperature	T_{STG}	-55 to +125	°C	

The absolute maximum ratings are limiting values, to be applied individually, beyond which the device may be permanently damaged. Functional operation under any of these conditions is not guaranteed. Exposing a circuit to its absolute maximum rating for extended periods of time may affect the device's reliability.

Note: The HA166008MP has H0X, H0Y to H3X, H3Y.

The HA166009MP has H0X, H0Y to H5X, H5Y.

The HA166010MP has H0X, H0Y to H7X, H7Y.

Table 3 Power Supply ($T_a=25^\circ\text{C}$)

Item	Symbol	Min	Typ	Max	Unit	Test Conditions	Note
Supply voltage range	V_5	4.5	5.0	5.5	V		1
Supply voltage range	V_{12}	10.8	12	13.2	V		↓
+5V supply current	I_5	—	15	25	mA	Read mode $V_{12}=13.2\text{V}$ $V_5=5.5\text{V}$	↓
+5V supply current	I_5	—	20	30	mA	Write mode $V_{12}=13.2\text{V}$ $V_5=5.5\text{V}$	↓
+5V supply current	I_5	—	8	13	mA	Idle mode $V_{12}=13.2\text{V}$ $V_5=5.5\text{V}$	↓
+12V supply current	I_{12}	—	38	55	mA	Read mode $V_{12}=13.2\text{V}$ $V_5=5.5\text{V}$	2
+12V supply current	I_{12}	—	$15+I_w$	$25+I_w$	mA	Write mode $V_{12}=13.2\text{V}$ $V_5=5.5\text{V}$	↓



HA166008MP, HA166009MP, HA166010MP

Power Supply ($T_a=25^\circ C$) (cont)

+12V supply current	I12	—	16	25	mA	Idle mode V12=13.2V V5=5.5V	↓
+12V supply current	I12	—	40	60	mA	Read mode V12=13.2V V5=5.5V	3
+12V supply current	I12	—	18+Iw	30+Iw	mA	Write mode V12=13.2V V5=5.5V	↓
+12V supply current	I12	—	19	30	mA	Idle mode V12=13.2V V5=5.5V	↓

- Notes:
1. These specifications apply for the HA166008MP/009MP/010MP.
 2. Apply for the HA166008MP.
 3. Apply for the HA166009MP/010MP.

Table 4 Electrical Characteristics (HA166008MP/009MP/010MP)
($V_{12}=12V$, $V_5=5V$, $T_a=25^\circ C$ Unless otherwise specified.)

Digital Input

Item	Symbol	Min	Typ	Max	Unit	Test Conditions
Low level input voltage	V_{IL}	-0.3	—	-0.8	V	
Low level input current	I_{IL}	-400	—	—	μA	$V_{IL}=0.8V$, (WDI in apply)
Low level input current	I_{IL}	-100	—	—	μA	$V_{IL}=0.8V$, (HS0, HS1, HS2, CD, R/W in apply)
High level input voltage	V_{IH}	2.0	—	$V_5+0.3$	V	
High level input current	I_{IH}	—	—	100	μs	$V_{IH}=2.0V$
Read/write transition time	t_{rw}	—	—	600	ns	R/W to 90% VCT write voltage
Write/read transition time	t_{wr}	—	—	600	ns	R/W to 90% VCT read voltage
Head select switching delay time	t_{hs}	—	—	600	ns	Read or write mode
Chip disable transition time	t_{iaw}	—	—	600	ns	R/W to idle or idle to R/W



HA166008MP, HA166009MP, HA166010MP

Write Faults Detection

Item	Symbol	Min	Typ	Max	Unit	Test Conditions
Low level US voltage	V _{OL}	—	—	0.5	V	I _{OL} =8mA
High level US current	I _{OH}	—	—	100	μA	V _{OH} =5.0V
Unsafe to safe delay time	t _{d2}	—	—	1.0	μs	
Safe to unsafe delay time	t _{d1}	1.6	—	8.0	μs	

Head Select • Table

HS2	HS1	HS0	Head Select
L	L	L	0
L	L	H	1
L	H	L	2
L	H	H	3
H	L	L	4
H	L	H	5
H	H	L	6
H	H	H	7

Mode Select • Table

CD	R/W	Mode
L	L	Write
L	H	Read
H	L	Idle
H	H	Idle

Read Amplifier

Item	Symbol	Min	Typ	Max	Unit	Test Conditions
Differential voltage gain	Avd	170	200	230	V/V	f=300kHz
Band width (-3dB)	BW	40	—	—	MHz	
Input noise voltage	V _n	—	—	1.0	nV/√Hz	f≤15MHz, Input short
Input bias current	I _B	—	60	120	μA	Read mode (per side)
Common mode rejection ratio	CMRR	50	—	—	dB	V _{in(cm)} =V _{CT} +100mVpp, 0.0VDC, f=5MHz



HA166008MP, HA166009MP, HA166010MP

Read Amplifier (cont)

Power supply rejection ratio	PSRR	45	—	—	dB	V5, V12±100mVpp, f=5MHz
Channel separation	Sep	45	—	—	dB	Vin=100mVpp, f=5MHz on unselected channels and Vin=0mVpp on selected channels
Output offset voltage	Vo	—600	—	600	mV	Input short
Differential input impedance	Rin	—	2.0	—	kΩ	f=300MHz
Differential input impedance	Rin	—	1.3	—	kΩ	f=5MHz
Common mode output voltage	Vocm	5.0	6.0	7.0	V	
Output source current	—	—10	—	—	mA	
Output sink current	Ios	2.0	2.5	—	mA	

Write Driver

Item	Symbol	Min	Typ	Max	Unit	Test Conditions
Write current setting range	Iw	10	—	50	mA	Iw·Lhead>200mA·μH
Head current rise time	t _{hcx}	—	—	20	ns	Lh=0μH, Rh=0Ω, 10% to 90% point
Head current switching delay time	t _{d3}	—	—	25	ns	Rh=0Ω, Lh=0μH, from 50% point
Head current switching symmetry	t _{d4}	—	—	2	ns	WDI Duty=50%, rise/fall time=1ns
WDI minimum input frequency	f _w	125	—	—	kHz	WUS=LOW
Head current gain	I _h /I _{wc}	—	20	—		Head current/I _{wc}
VCT output voltage	V _{CT}	3.8	4.3	4.8	V	Read mode I _b =−120μA
	V _{CT}	5.0	6.0	6.6	V	Write mode I _{wc} =−45mA
Write current accuracy	I _{h1}	9.3	10.0	10.7	mA	R _{wc} =9.38kΩ
	I _{h2}	27.9	30.0	32.1	mA	R _{wc} =3.00kΩ
	I _{h3}	46.5	50.0	53.5	mA	R _{wc} =1.73kΩ
K is calculated by the following equation	K=95.51−0.176·I _h (mA)					



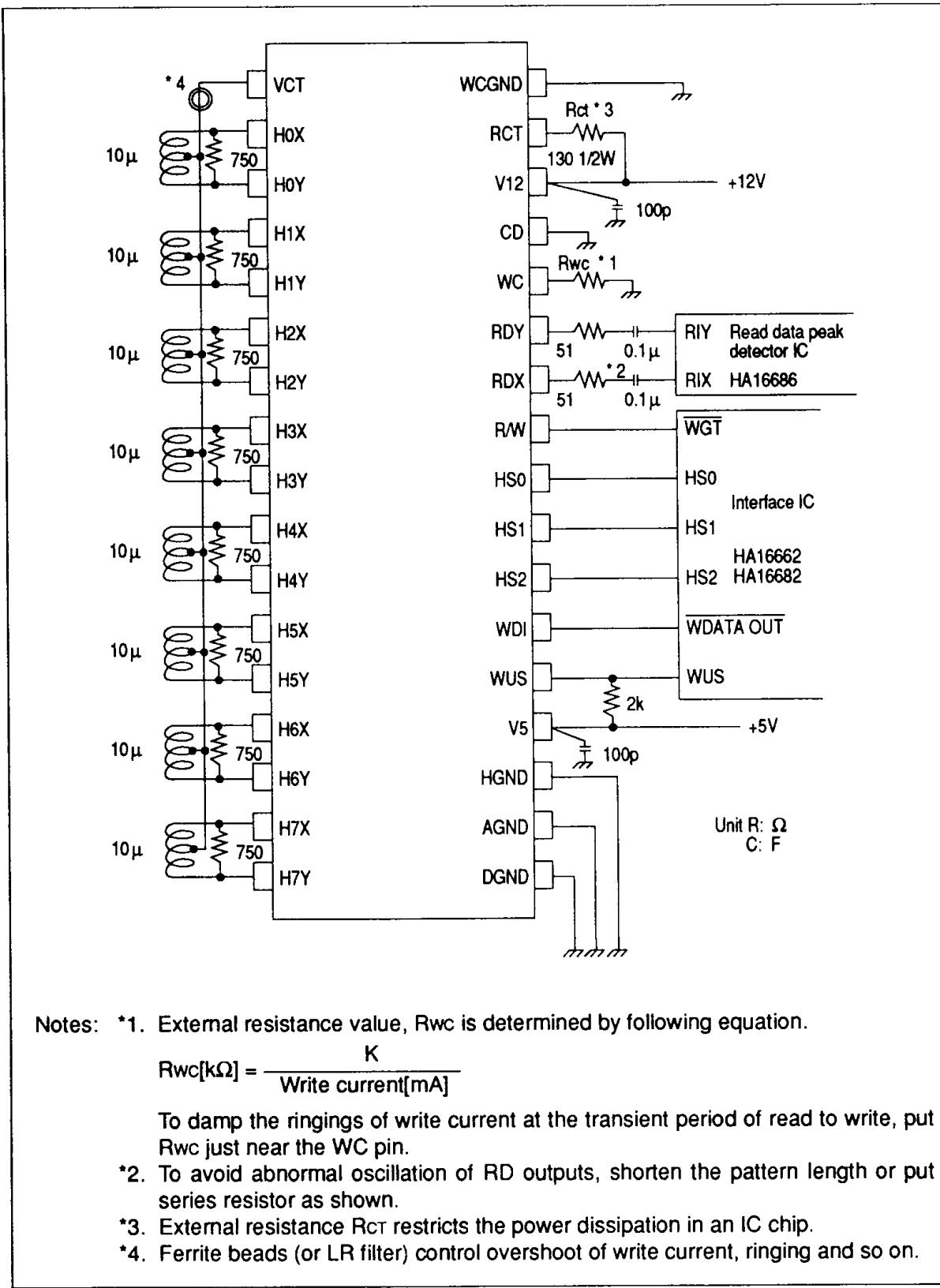


Figure 3 Circuit Example

 **HITACHI**

Hitachi America, Ltd. • Hitachi Plaza • 2000 Sierra Point Pkwy. • Brisbane, CA 94005-1819 • (415) 589-8300

243